

Special Issue

Advances in Diagnostic and Therapeutic Radiology—3rd Edition

Message from the Guest Editor

This Special Issue focuses on the wide range of advances being made in the various clinical and technical aspects of medical imaging, diagnostic and therapeutic nuclear medicine, radiation oncology, radiation protection, and the biological effects of ionizing radiation. Articles on a broad spectrum of topics, including all aspects of clinical and/or basic research that describe original observations, techniques, instruments, new technologies, and meta-analyses, are welcomed.

Guest Editor

Dr. Miguel Alcaraz

1. Radiology and Physical Medicine Department, School of Medicine, University of Murcia, 30100 Murcia, Spain
2. Instituto Murciano de Investigación Biosanitaria "Virgen de la Arrixaca" (IMIB-Arrixaca), 30100 Murcia, Spain

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Applied Sciences
Editorial Office
MDPI, Grosspeteranlage 5
4052 Basel, Switzerland
Tel: +41 61 683 77 34
appls@mdpi.com

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Message from the Editor-in-Chief

As the world of science becomes ever more specialized, researchers may lose themselves in the deep forest of the ever increasing number of subfields being created. This open access journal Applied Sciences has been started to link these subfields, so researchers can cut through the forest and see the surrounding, or quite distant fields and subfields to help develop his/her own research even further with the aid of this multi-dimensional network.

Editor-in-Chief

Prof. Dr. Giulio Nicola Cerullo
Dipartimento di Fisica, Politecnico di Milano, Piazza L. da Vinci 32,
20133 Milano, Italy

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